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- State-of-the-Art BiCMOS Design Significantly Reduces I_{CCZ}
- ESD Protection Exceeds 2000 V Per MIL-STD-883C, Method 3015
- Output Ports Have Equivalent 33-Ω Series Resistors, So No External Resistors Are Required
- 3-State Inverting Outputs Drive Bus Lines or Buffer Memory Address Registers
- Flow-Through Architecture Optimizes PCB Layout
- Package Options Include Plastic Small-Outline (DW) Packages, Ceramic Chip Carriers (FK) and Flatpacks, and Standard Plastic and Ceramic 300-mil DIPs (JT, NT)

description

These 10-bit bus/MOS memory drivers provide a high-performance bus interface for wide data paths or buses carrying parity.

The 3-state control gate is a 2-input AND gate with active-low inputs so that if either output-enable $(\overline{OE1} \text{ or } \overline{OE2})$ input is high, all ten outputs are in the high-impedance state. The outputs are also in the high-impedance state during power-up and power-down conditions. The outputs remain in the high-impedance state while the device is powered down.

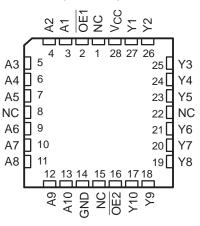
The outputs, which are designed to source or sink up to 12 mA, include $33-\Omega$ series resistors to reduce overshoot and undershoot.

The SN54BCT2828A is characterized for operation over the full military temperature range of -55° C to 125° C. The SN74BCT2828B is characterized for operation from 0°C to 70°C.

(TOP VIEW)								
OE1		24 V _{CC}						
A1 [2	23] Y1						
A2 [3	22 🛛 Y2						
A3 [4	21 🛛 Y3						
A4 [5	20 🛛 Y4						
A5 [6	19 🛛 Y5						
A6 [7	18 🛛 Y6						
A7 [8	17 🛛 Y7						
A8 [9	16 🛛 Y8						
A9 [10	15 🛛 Y9						
A10 [11	14] <u>Y10</u>						
GND [12	13 OE2						

SN54BCT2828A ... JT OR W PACKAGE SN74BCT2828B ... DW OR NT PACKAGE

SN54BCT2828A . . . FK PACKAGE (TOP VIEW)



NC - No internal connection

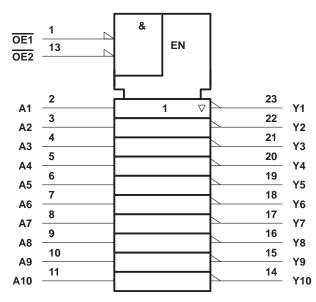
FUNCTION TABLE								
	INPUTS	OUTPUT						
OE1	OE2	Α	Y					
L	L	L	Н					
L	L	Н	L					
Н	Х	Х	Z					
Х	Н	Х	Z					

FUNCTION TADLE

PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.

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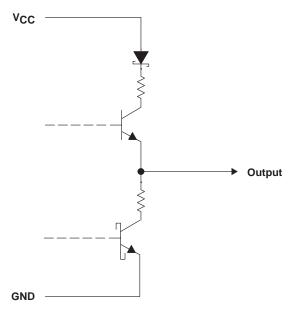
logic symbol[†]



[†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

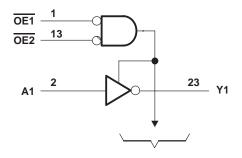
Pin numbers shown are for the DW, JT, NT, and W packages.

schematic of each output





logic diagram (positive logic)



To Nine Other Channels

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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[†]

Supply voltage range, V_{CC} Input voltage range, V_I (see Note 1) Voltage range applied to any output in the disabled or power-off state, V_O Voltage range applied to any output in the high state, V_O Input clamp current, I_{IK} ($V_I < 0$) Current into any output in the low state, I_O Operating free-air temperature range: SN54BCT2828A	-0.5 V to 7 V -0.5 V to 7 V -0.5 V to 7 V -0.5 V to V _{CC} 30 mA 24 mA 55°C to 125°C
SN74BCT2828B	0°C to 70°C
Storage temperature range6	35°C to 150°C

† Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: The input negative-voltage rating may be exceeded if the input clamp-current rating is observed.

recommended operating conditions (see Note 2)

		SN54BCT2828A			SN74BCT2828B			UNIT
		MIN	NOM	MAX	MIN	NOM	MAX	UNIT
VCC	Supply voltage	4.5	5	5.5	4.5	5	5.5	V
VIH	High-level input voltage	2			2			V
VIL	Low-level input voltage			0.8			0.8	V
Iк	Input clamp current			-18			-18	mA
IOH	High-level output current	-1		-1	mA			
IOL	Low-level output current			12			12	mA
Т _А	Operating free-air temperature	-55		125	0		70	°C

NOTE 2: Unused or floating inputs must be held high or low.

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

DADAMETER	TEST CONDITIONS		SN5	4BCT28	28A	SN74	UNIT		
PARAMETER			MIN	TYP‡	MAX	MIN	typ‡	MAX	UNIT
VIK	V _{CC} = 4.5 V,	I _I = -18 mA			-1.2			-1.2	V
VOH	$V_{CC} = 4.5 V \text{ to } 5.5 V,$	$I_{OH} = -1 \text{ mA}$	V _{CC} -2			V _{CC} -2			V
Ve		I _{OL} = 1 mA		0.35	0.5		0.35	0.5	V
VOL	V _{CC} = 4.5 V	I _{OL} = 12 mA					0.42	0.8	V
lj	V _{CC} = 5.5 V,	$V_{I} = 7 V$			0.1			0.1	mA
ЧН	V _{CC} = 5.5 V,	V _I = 2.7 V			20			20	μΑ
١ _{١L}	V _{CC} = 5.5 V,	V _I = 0.5 V			-0.2			-0.2	mA
IOZH	V _{CC} = 5.5 V,	V _O = 2.7 V			20			20	μΑ
I _{OZL}	V _{CC} = 5.5 V,	V _O = 0.5 V			-20			-20	μΑ
I _{OL}	V _{CC} = 4.5 V,	V _O = 2 V	50			50			mA
١ ₀ §	V _{CC} = 5.5 V,	V _O = 2.25 V	-30		-112	-30		-112	mA
ICCL	V _{CC} = 5.5 V,	Outputs open		28			28	40	mA
Iccz	V _{CC} = 5.5 V,	Outputs open		3.5			3.5	6	mA
Ci	V _{CC} = 5 V,	VI = 2.5 V or 0.5 V		5			5		pF
Co	V _{CC} = 5 V,	$V_{O} = 2.5 \text{ V or } 0.5 \text{ V}$		8			8		pF

[‡] All typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$.

§ Not more than one output should be tested at a time, and the duration of the test should not exceed one second.



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switching characteristics over recommended ranges of supply voltage and operating free-air temperature, $C_L = 50 \text{ pF}$ (unless otherwise noted) (see Note 3)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V (Т,	CC = 5 V A = 25°C	/, ;	SN54BCT	2828A	SN74BC1	72828B	UNIT	
			MIN	TYP	MAX	MIN	MAX	MIN	MAX		
^t PLH	A	v	1.8	2.7	5.9	1.5	10	1.3	6.6	20	
^t PHL		T	1.2	3.1	4.8	1.5	9	0.9	5	ns	
^t PZH	OE	05	V	3.6	5.8	7.8	2	15	2.9	9	20
^t PZL		T	5.5	7.9	10.2	2	21	4.8	11.5	ns	
^t PHZ	OE	v	4.7	7.2	9.3	2	18	3.8	10.8		
^t PLZ	UE	r	3.3	5.4	7.2	2	15	2.7	8.7	ns	

NOTE 3: Load circuits and voltage waveforms are shown in Section 1.



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